TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74LCX573F,TC74LCX573FW,TC74LCX573FT

Low-Voltage Octal D-Type Latch with 5-V Tolerant Inputs and Outputs

The TC74LCX573F/FW/FT is a high-performance CMOS octal D-type latch. Designed for use in 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

The device is designed for low-voltage (3.3 V) V_{CC} applications, but it could be used to interface to 5-V supply environment for both inputs and outputs.

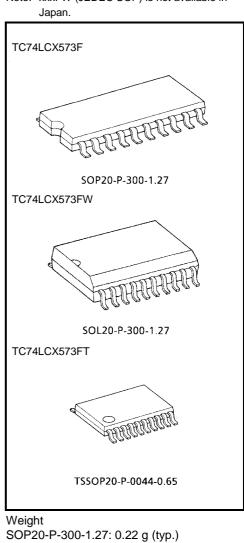
This 8-bit D-type latch is controlled by a latch enable input (LE) and an output enable input ($\overline{\text{OE}}$).

When the \overline{OE} input is high, the eight outputs are in a high-impedance state.

All inputs are equipped with protection circuits against static discharge.

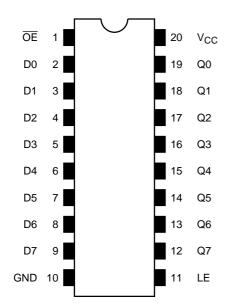
Features

- Low-voltage operation: $V_{CC} = 2.0$ to 3.6 V
- High-speed operation: tpd = 8.0 ns (max) (VCC = 3.0 to 3.6 V)
- Output current: $|I_{OH}|/I_{OL} = 24 \text{ mA} (\text{min}) (V_{CC} = 3.0 \text{ V})$
- Latch-up performance: ±500 mA
- Available in JEDEC SOP, JEITA SOP and TSSOP
- Power-down protection provided on all inputs and outputs
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 573 type



SOP20-P-300-1.27: 0.22 g (typ.) SOL20-P-300-1.27: 0.46 g (typ.) TSSOP20-P-0044-0.65: 0.08 g (typ.)

Pin Assignment (top view)



Truth Table

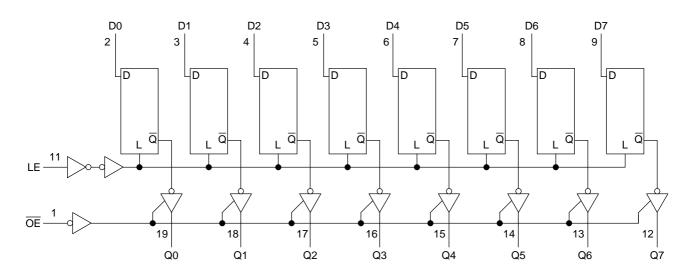
	Inputs	Outpute			
ŌĒ	LE	D Outputs			
Н	Х	Х	Z		
L	L	Х	Qn		
L	Н	L	L		
L	Н	Н	Н		

X: Don't care

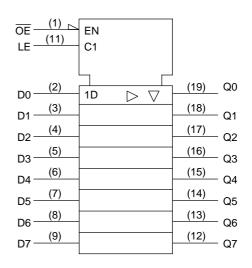
Z: High impedance

Qn: Q outputs are latched at the time when the LE input is taken to a low logic level.

System Diagram



IEC Logic Symbol



Maximum Ratings

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CC}	-0.5 to 7.0	V
DC input voltage	V _{IN}	-0.5 to 7.0	V
		-0.5 to 7.0 (Note 1)	
DC output voltage	V _{OUT}	-0.5 to V _{CC} + 0.5	V
		(Note 2)	
Input diode current	I _{IK}	-50	mA
Output diode current	IOK	±50 (Note 3)	mA
DC output current	IOUT	±50	mA
Power dissipation	PD	180	mW
DC V _{CC} /ground current	I _{CC} /I _{GND}	±100	mA
Storage temperature	T _{stg}	–65 to 150 °	

Note 1: Output in OFF state

Note 2: High or low state. $I_{\mbox{OUT}}$ absolute maximum rating must be observed.

Note 3: $V_{OUT} < GND, V_{OUT} > V_{CC}$

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V _{CC}	2.0 to 3.6	V	
i ower supply voltage	vcc	1.5 to 3.6 (Note 4)	v	
Input voltage	V _{IN}	0 to 5.5	V	
	VOUT	0 to 5.5 (Note 5)	V	
Output voltage		0 to V _{CC} (Note 6)	v	
Output ourroot	1 /1	±24 (Note 7)	mA	
Output current	I _{OH} /I _{OL}	±12 (Note 8)	IIIA	
Operating temperature	T _{opr}	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 10 (Note 9)	ns/V	

Note 4: Data retention only

Note 5: Output in OFF state

Note 6: High or low state

Note 7: $V_{CC} = 3.0$ to 3.6 V

Note 8: $V_{CC} = 2.7$ to 3.0 V

Note 9: $V_{IN} = 0.8$ to 2.0 V, $V_{CC} = 3.0$ V

Electrical Characteristics

DC Characteristics (Ta = -40 to 85° C)

Characteris	stics	Symbol	Test	Condition	V _{CC} (V)	Min	Max	Unit	
1 <i>i</i> 1	H-level	VIH		_		2.0			
Input voltage	L-level	VIL		_	2.7 to 3.6		0.8	V	
				I _{OH} = -100 μA	2.7 to 3.6	V _{CC} - 0.2	_		
	H-level	V _{OH}	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -12 \text{ mA}$	2.7	2.2	_		
				I _{OH} = -18 mA	3.0	2.4	_		
Output voltage				I _{OH} = -24 mA	3.0	2.2	_	V	
			$V_{IN} = V_{IH} \text{ or } V_{IL}$	I _{OL} = 100 μA	2.7 to 3.6		0.2		
		Max		I _{OL} = 12 mA	2.7	_	0.4	-	
	L-level	V _{OL}		I _{OL} = 16 mA	3.0	_	0.4		
					I _{OL} = 24 mA	3.0	_	0.55	
Input leakage current	t	I _{IN}	$V_{IN} = 0$ to 5.5 V		2.7 to 3.6	_	±5.0	μA	
3-state output OFF s	tate current	I _{OZ}	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \text{ to } 5.5 \text{ V}$		2.7 to 3.6	_	±5.0	μA	
Power-off leakage cu	irrent	IOFF	$V_{IN}/V_{OUT} = 5.5 V$		0	_	10.0	μA	
	ront	. VI	$V_{IN} = V_{CC}$ or GND		V _{IN} = V _{CC} or GND		_	10.0	
Quiescent supply cur	rent	ICC	$V_{IN}/V_{OUT} = 3.6$ to 5.5 V		2.7 to 3.6	_	±10.0	μA	
Increase in I _{CC} per ir	nput	ΔI_{CC}	$V_{IH} = V_{CC} - 0.6 V$		2.7 to 3.6	_	500		

AC Characteristics (Ta = -40 to 85°C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
Propagation delay time	t _{pLH}	Figure 1 Figure 2	2.7	_	9.0	
(D-Q)	t _{pHL}	Figure 1, Figure 2	$\textbf{3.3}\pm\textbf{0.3}$	1.5	8.0	ns
Propagation delay time	t _{pLH}	Figure 4 Figure 2	2.7	_	9.5	
(LE-Q)	t _{pHL}	Figure 1, Figure 2	$\textbf{3.3}\pm\textbf{0.3}$	1.5	8.5	ns
Output anabla time	t _{pZL}	Figure 4. Figure 2	2.7	_	9.5	ns
Output enable time	t _{pZH}	Figure 1, Figure 3	$\textbf{3.3}\pm\textbf{0.3}$	1.5	8.5	
Output diaghla time	t _{pLZ}	Figure 4 Figure 2	2.7	_	7.0	ns
Output disable time	t _{pHZ}	Figure 1, Figure 3	$\textbf{3.3}\pm\textbf{0.3}$	1.5	6.5	
Minimum pulse width	+ (LI)		2.7	3.3		ns
(LE)	t _w (H)	Figure 1, Figure 2	$\textbf{3.3}\pm\textbf{0.3}$	3.3		
Minimum onton times	t _s	Figure 1, Figure 2	2.7	2.5		
Minimum setup time			$\textbf{3.3}\pm\textbf{0.3}$	2.5		ns
Minimum hold time	t _h		2.7	1.5		
		Figure 1, Figure 2	$\textbf{3.3}\pm\textbf{0.3}$	1.5		ns
6	t _{osLH}	(Note 10)	2.7	_	—	
Output to output skew	t _{osHL}		$\textbf{3.3}\pm\textbf{0.3}$	_	1.0	ns

Note 10: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{pLHm} - t_{pLHn}|, t_{OSHL} = |t_{pHLm} - t_{pHLn}|)$

Dynamic Switching Characteristics

(Ta = 25°C, input: $t_r = t_f = 2.5$ ns, $C_L = 50$ pF, $R_L = 500 \Omega$)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Quiet output maximum dynamic V _{OL}	V _{OLP}	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	0.8	V
Quiet output minimum dynamic V _{OL}	V _{OLV}	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	0.8	V

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition		V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}	_		3.3	7	pF
Output capacitance	C _{OUT}			3.3	8	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz (Not	te 11)	3.3	25	pF

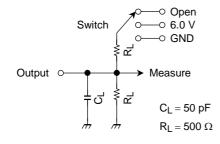
Note 11: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per bit)}$

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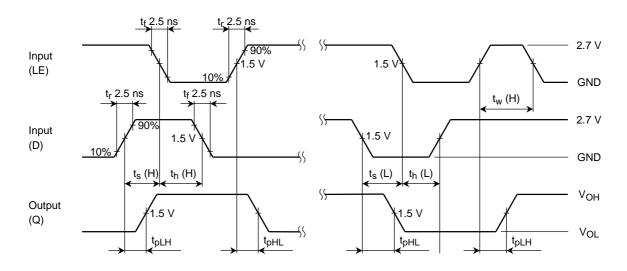
AC Test Circuit



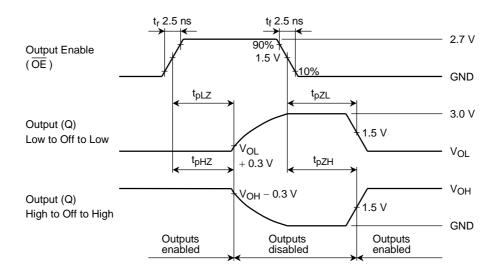
Parameter	Switch
t _{pLH} , t _{pHL}	Open
t _{pLZ} , t _{pZL}	6.0 V
t _{pHZ} , t _{pZH}	GND
t _w , t _s , t _h	Open

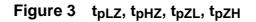


AC Waveform



 $\label{eq:Figure 2} \quad t_{pLH}, t_{pHL}, t_w, t_s, t_h$

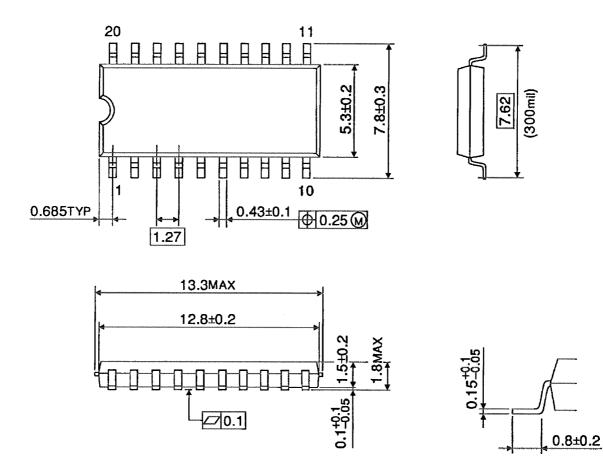




Package Dimensions

SOP20-P-300-1.27

Unit : mm

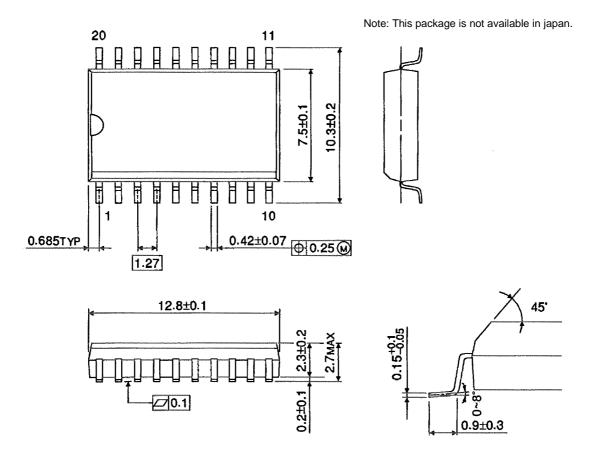


Weight: 0.22 g (typ.)

Package Dimensions

SOL20-P-300-1.27

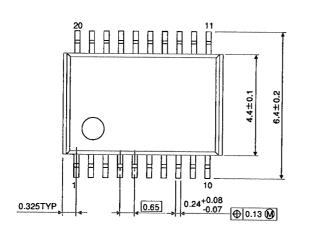
Unit : mm



Weight: 0.46 g (typ.)

Package Dimensions

TSSOP20-P-0044-0.65



6.75MAX

6.5±0.1

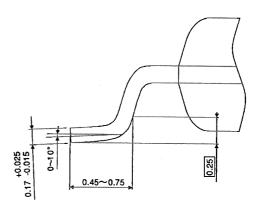
- 🔲 0.1

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1.0±0.05 1.2MAX

0.1±0.05

Unit : mm



Weight: 0.08 g (typ.)

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